Notice of References Cited Application/Control No. 10/073,636 Examiner ANNAN Q. SHANG Applicant(s)/Patent Under Reexamination AVISON, BEN Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,445,738	09-2002	Zdepski et al.	375/240.01
*	В	US-5,799,128	08-1998	Van Den Enden, Gijsbert J.	386/353
*	C	US-7,023,924	04-2006	Keller et al.	375/240.26
*	D	US-6,879,770	04-2005	Van Asten et al.	386/346
*	Е	US-6,658,056	12-2003	Duruoz et al.	375/240
*	F	US-6,389,218	05-2002	Gordon et al.	386/314
*	G	US-6,353,700	03-2002	Zhou, Changguo	386/353
*	Ι	US-6,141,491	10-2000	Yamagishi et al.	386/329
*	I	US-6,023,553	02-2000	Boyce et al.	386/329
*	٦	US-5,867,176	02-1999	Yamagishi, Tooru	345/473
*	К	US-5,842,046	11-1998	Kajitani, Kouichi	710/74
*	L	US-5,768,537	06-1998	Butter et al.	709/247
*	М	US-6,871,006	03-2005	Oguz et al.	386/346

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.